

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

The SSG9435P is the highest performance trench P-ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The SSG9435P meet the RoHS and Green Product requirement with full function reliability approved.

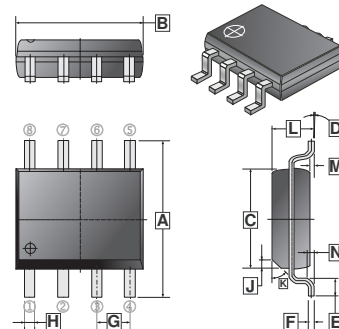
FEATURES

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Green Device Available

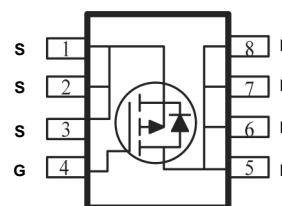
PACKAGE INFORMATION

Package	MPQ	Leader Size
SOP-8	2.5K	13 inch

SOP-8



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.79	6.20	H	0.33	0.51
B	4.70	5.11	J	0.375 REF.	
C	3.80	4.00	K	45° REF.	
D	0°	8°	L	1.3	1.752
E	0.40	1.27	M	0	0.25
F	0.10	0.25	N	0.25 REF.	
G	1.27 TYP.				



MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹ @ $V_{GS}=10\text{V}$	$T_A=25^\circ\text{C}$	-5	A
	$T_A=70^\circ\text{C}$	-4	A
Pulsed Drain Current ³	I_{DM}	-25	A
Total Power Dissipation	$T_A=25^\circ\text{C}$	2.5	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 ~ 150	$^\circ\text{C}$
Thermal Resistance Rating			
Maximum Thermal Resistance from Junction to Ambient ¹	$R_{\theta JA}$	$t \leq 10\text{sec}, 50$	$^\circ\text{C} / \text{W}$
		Steady State, 83	
Maximum Thermal Resistance from Junction to Ambient ²	$R_{\theta JA}$	125	
Maximum Thermal Resistance from Junction to Case ¹	$R_{\theta JC}$	25	

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Drain-Source Breakdown Voltage	BV_{DSS}	-30	-	-	V	$V_{GS}=0, I_D=-250\mu\text{A}$
Gate-Threshold Voltage	$V_{GS(th)}$	-1	-1.5	-2	V	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$
Forward Transfer conductance	g_{fs}	-	11	-	S	$V_{DS}=-5\text{V}, I_D=-4\text{A}$
Gate-Body Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	-1	μA	$V_{DS}=-24\text{V}, V_{GS}=0\text{V}$
		-	-	-5		$V_{DS}=-24\text{V}, V_{GS}=0\text{V}, T_J=55^\circ\text{C}$
Drain-Source On-Resistance ⁴	$R_{DS(ON)}$	-	38	48	mΩ	$V_{GS}=-10\text{V}, I_D=-4\text{A}$
		-	54	75		$V_{GS}=-4.5\text{V}, I_D=-3\text{A}$
Total Gate Charge	Q_g	-	6.4	-	nC	$I_D=-4\text{A}$ $V_{DS}=-15\text{V}$ $V_{GS}=-4.5\text{V}$
Gate-Source Charge	Q_{gs}	-	2.3	-		
Gate-Drain("Miller") Charge	Q_{gd}	-	2	-		
Turn-On Delay Time	$T_{d(on)}$	-	2.8	-	nS	$V_{DD}=-15\text{V}$ $I_D=-4\text{A}$ $V_{GS}=-10\text{V}$ $R_G=3.3\Omega$
Rise Time	T_r	-	8.4	-		
Turn-Off Delay Time	$T_{d(off)}$	-	39	-		
Fall Time	T_f	-	6	-		
Input Capacitance	C_{iss}	-	585	-	pF	$V_{GS}=0\text{V}$ $V_{DS}=-15\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	100	-		
Reverse Transfer Capacitance	C_{rss}	-	85	-		
Source-Drain Diode						
Continuous Source Current ¹	I_S	-	-	-5	A	
Pulsed Source Current ³	I_{SM}	-	-	-25	A	
Diode Forward Voltage ⁴	V_{SD}	-	-0.8	-1.2	V	$V_{GS}=0\text{V}, I_S=-2.1\text{A}, T_J=25^\circ\text{C}$
Reverse Recovery Time	t_{rr}	-	7.8	-	nS	$I_F=-4\text{A}, di/dt=100\text{A}/\mu\text{s}, T_J=25^\circ\text{C}$
Reverse Recovery Charge	Q_{rr}	-	2.5	-	nC	

Notes:

- Surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- when mounted on Min. copper pad.
- The power dissipation is limited by 150°C junction temperature
- The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$

CHARACTERISTIC CURVE

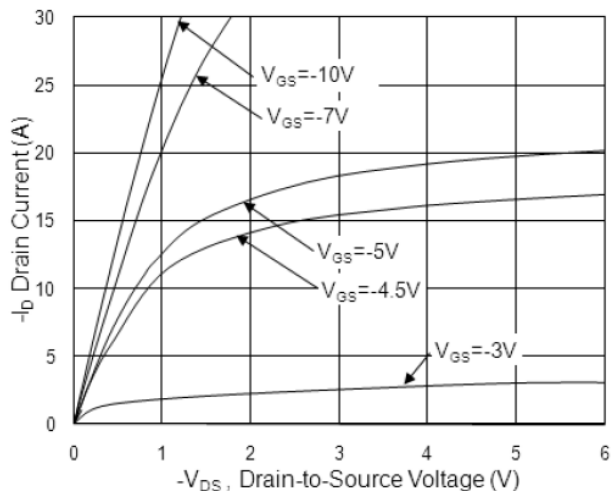


Fig.1 Typical Output Characteristics

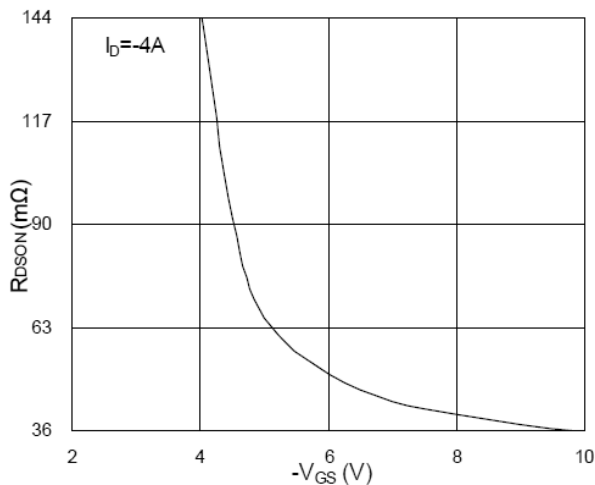


Fig.2 On-Resistance vs. Gate-Source

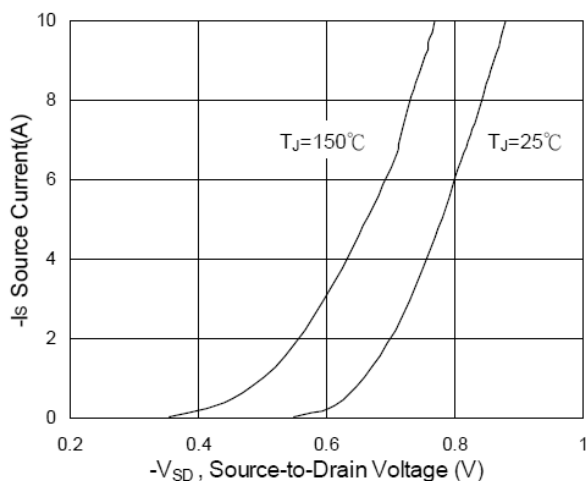


Fig.3 Forward Characteristics of Reverse

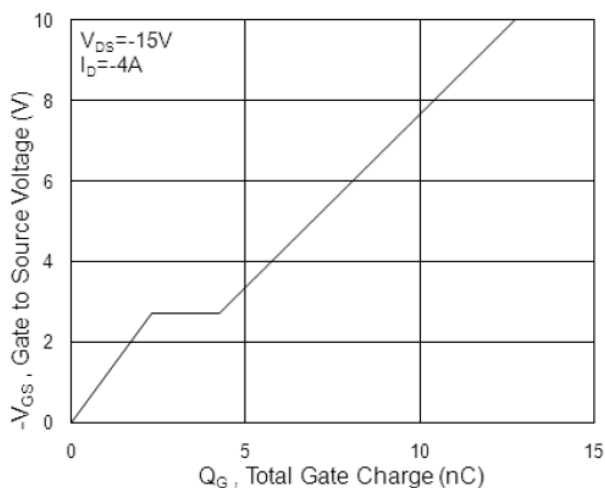


Fig.4 Gate-Charge Characteristics

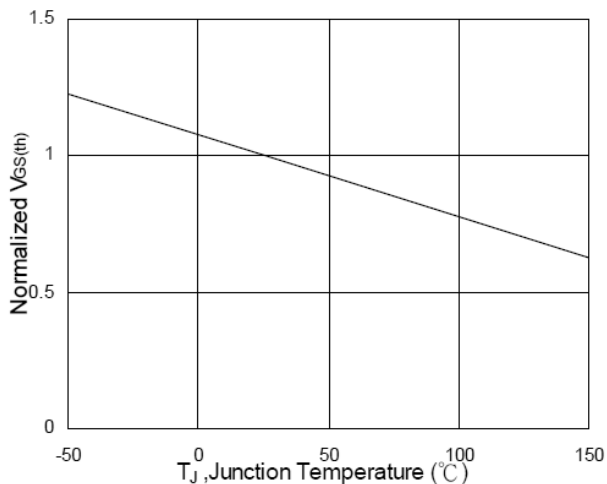


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

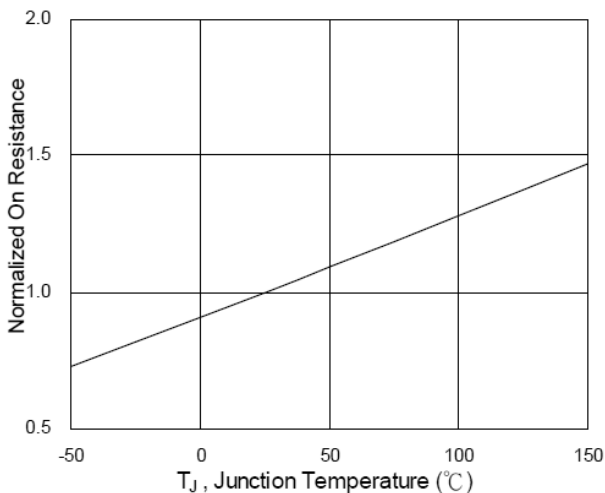


Fig.6 Normalized $R_{DS(ON)}$ vs. T_J

CHARACTERISTIC CURVE

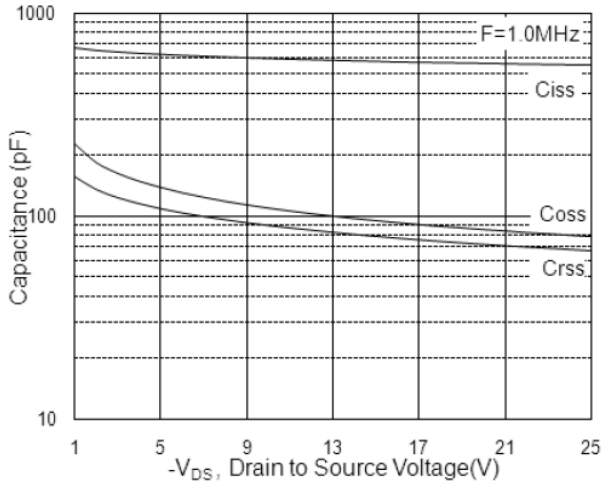


Fig.7 Capacitance

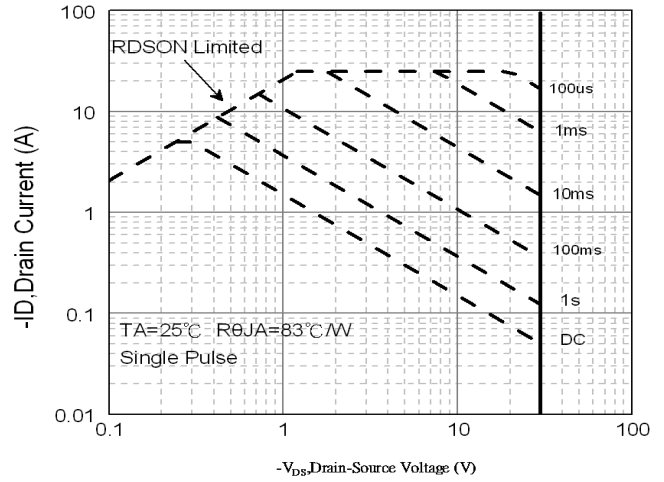


Fig.8 Safe Operating Area

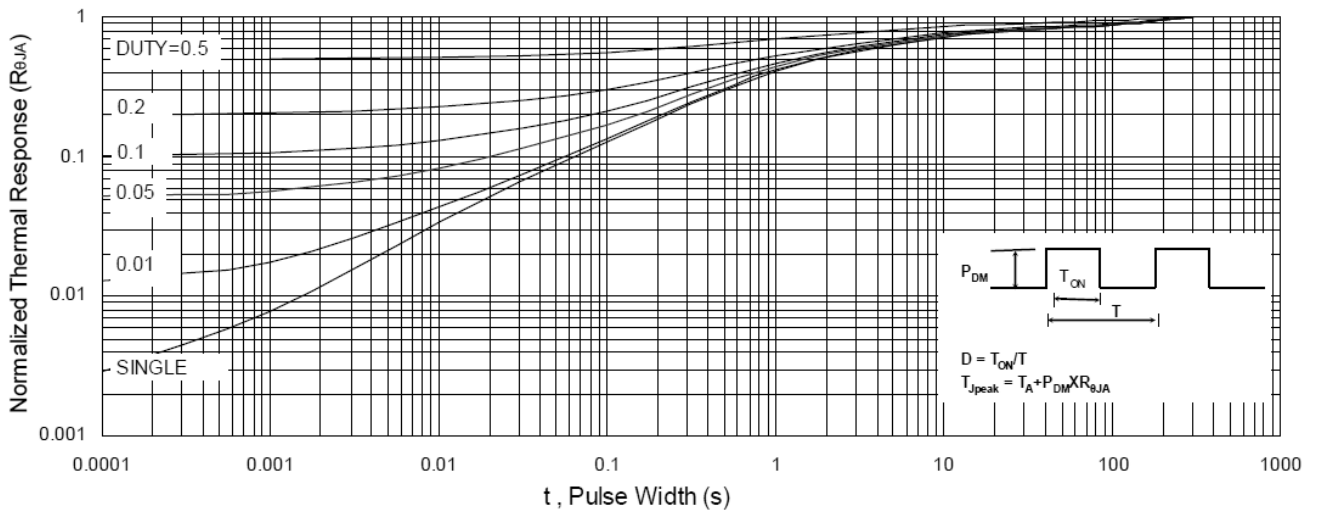


Fig.9 Normalized Maximum Transient Thermal Impedance

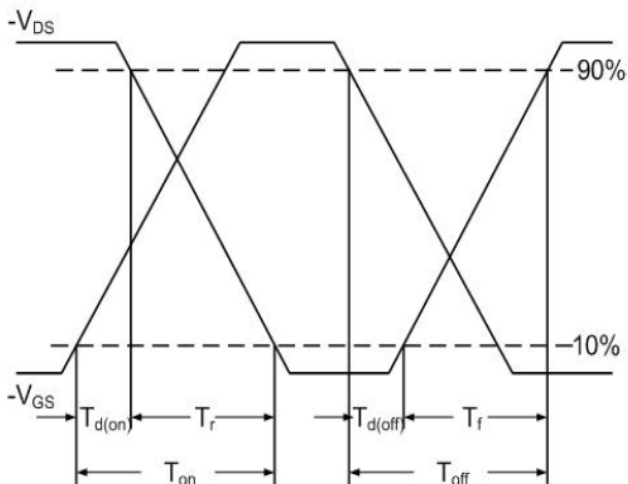


Fig.10 Switching Time Waveform

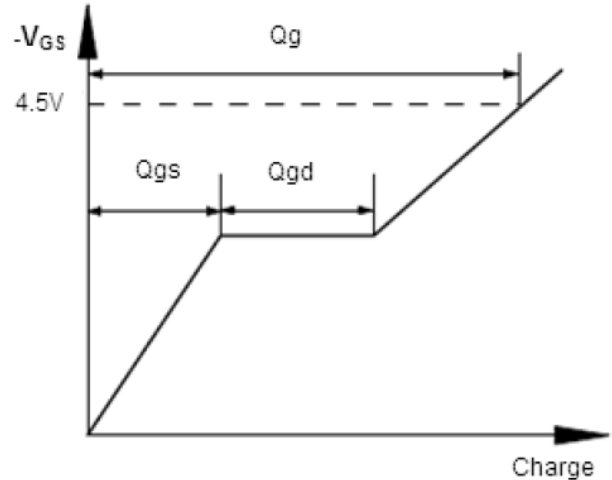


Fig.11 Gate Charge Waveform